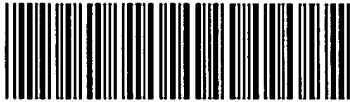


Search Notes



Application/Control No.

10/726,592

Examiner

Kin-Chan Chen

Applicant(s)/Patent under Reexamination

YOSHIOKA ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	689	10/20/2005	KCC
438	692		
252	79.1		
252	79.5	10/20/05	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East keywords search USPT, USPG-pub. Epo, Jpo, Derwent IBM TDB, inventor search.	10/20/2005	KCC